


<b>Search Notes</b>  	<b>Application/Control No.</b>  10700764	<b>Applicant(s)/Patent Under Reexamination</b>  LAUCH, RICHARD
	<b>Examiner</b>  Kruer, Stefan	<b>Art Unit</b>  3654

SEARCHED			
Class	Subclass	Date	Examiner
187	298, 299, 377	02/05/2007	SHK
220	3.3, 210,212.5,262		
70	371,38,35,42,69,144,192,202,241,254		
B66B	11/00, 11/08, 1/46	07/12/2007	SHK
E05B	13/\$\$\$		
B65H	59/16		
B66D	5/\$\$\$		

SEARCH NOTES		
Search Notes	Date	Examiner

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner